## Notice of References Cited Application/Control No. 10/027,870 Examiner David Buttner David Buttner Applicant(s)/Patent Under Reexamination WARTH ET AL. Page 1 of 1 U.S. PATENT DOCUMENTS

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	Α	US-4,056,504	11-1977	Grundmeier et al.	523/307
	В	US-			
	С	US-			
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	E	US-			
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